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ATTY, DOCKET NO.		APPLICATION NO.	
TUMB-102 CIP	09/887,313		
APPLICANT			
Bandini <i>et al.</i>	:	·	
FILING DATE	-	GROUP	
lune 22 2001		2131	

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	Paul Callaha	2/19/02

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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## INFORMATION DISCLOSURE O STATEMENT BY APPLICANT Sheet 1 of 1

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Sheet 1 of 1

App. No.	09/887,313
Filing Date	June 22, 2001
First Named Inventor	Jean-Christophe Bandini
Art Unit	2137
Examiner Name	Paul E. Calahan
Attorney Docket No.	TUMB-102CIP

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Signature	Ital	Cullel	Considered	10-12-05
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